

DESCRIPTION

The H11AAx series optocoupler consists of two infrared emitting diodes connected in inverse parallel and optically coupled to an NPN silicon transistor in a standard 6 pin dual in line plastic package.

FEATURES

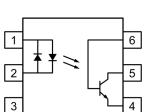
- High AC Isolation voltage 5000V_{RMS}
- Wide Operating Temperature Range
- -40°C to 100°C
- RoHS Compliant
- UL Approval E91231 Model "GG"
- VDE Approval 40028086

APPLICATIONS

- Computer Terminals
- Industrial System Controllers
- AC Input Response
- Signal Transmission between Systems of Different Potentials and Impedances

ORDER INFORMATION

- Add Suffix "X" for VDE Approval
- Add G after PN for 10mm lead spacing
- Add SM after PN for Surface Mount
- Add SMT&R after PN for Surface Mount Tape & Reel





- 1 Anode
- 2 Cathode
- 3 NC
- 4 Emitter
- 5 Collector
- 6 Base

ABSOLUTE MAXIMUM RATINGS $(T_A = 25^{\circ}C)$

Stresses exceeding the absolute maximum ratings can cause permanent damage to the device.

Exposure to absolute maximum ratings for long periods of time can adversely affect reliability.

Input

Forward Current	±50mA
Power Dissipation	70mW

Output

Collector Current	50mA
Collector to Emitter Voltage V_{CEO}	35V
Collector to Base Voltage V_{CBO}	35V
Emitter to Collector Voltage V _{ECO}	6V
Emitter to Base Voltage V _{EBO}	6V
Power Dissipation	150mW

Total Package

Total Power Dissipation	200mW
Isolation Voltage	$5000V_{\text{RMS}}$
Operating Temperature	-40 to 100°C
Storage Temperature	−55 to 125°C
Junction Temperature	125°C
Lead Soldering Temperature (10s)	260°C

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

INPUT

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward Voltage	V_{F}	$I_F = \pm 20 \text{mA}$		1.2	1.4	V
Terminal Capacitance	C_t	$V_F = 0V$, $f = 1kHz$		50	250	pF

OUTPUT

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector-Emitter Breakdown Voltage	BV _{CEO}	$I_C = 0.1 \text{mA}, I_F = 0 \text{mA}$	35			V
Emitter-Collector Breakdown Voltage	$\mathrm{BV}_{\mathrm{ECO}}$	$I_E=10\mu A,I_F=0mA$	6			V
Collector Dark Current	I_{CEO}	$V_{CE} = 20V, I_F = 0mA$			100	nA

COUPLED

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Current transfer ratio	CTR	$I_F = \pm 10 \text{mA}, V_{CE} = 10 \text{V}$				%
		H11AA1	20			
		H11AA2	10			
		H11AA3	50			
		H11AA4	100			
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_F = \pm 20 \text{mA}, I_C = 1 \text{mA}$			0.2	V
Floating Capacitance	C_{f}	$V_{IO} = 0V$, $f = 1MHz$		0.6	1	pF
Cut-Off Frequency	f_{C}	$V_{CE} = 5V, I_C = 2mA$ $R_L = 100\Omega, -3dB$	15	80		kHz
Output Rise Time	$t_{\rm r}$	$V_{CE} = 2V, I_C = 2mA$ $R_L = 100\Omega$		4	18	μs
Output Fall Time	$t_{ m f}$			3	18	μs



ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

ISOLATION

Parameter	Symbol	Test Condition	Min	Тур.	Max	Unit
Isolation Voltage	$V_{\rm ISO}$	R.H. = 40% to 60%, t = 1 min Note 1	5000			V_{RMS}
Isolation Resistance	R _{I-O}	$V_{\text{I-O}} = 500 \text{VDC}$ R.H. = 40% to 60% Note 1	5x10 ¹⁰	1x10 ¹¹		Ω

Note 1: Measured with input leads shorted together and output leads shorted together.



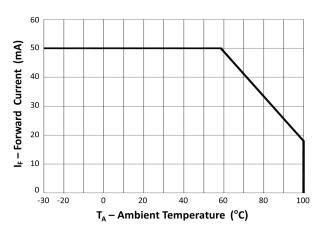


Fig 1 Forward Current vs Ambient Temperature

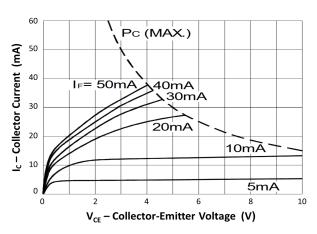


Fig 3 Collector Current vs Collector-Emitter Voltage

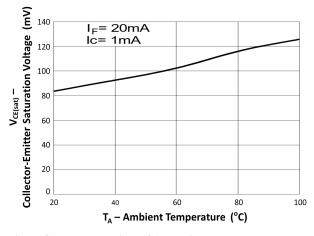


Fig 5 Collector-Emitter Saturation Voltage vs Ambient Temperature

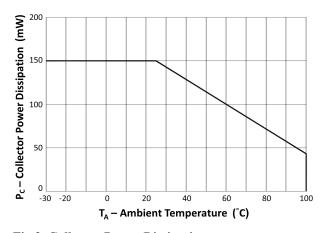


Fig 2 Collector Power Dissipation vs Ambient Temperature

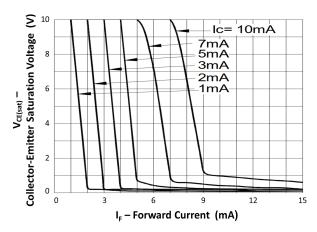


Fig 4 Collector-Emitter Saturation Voltage vs Forward Current

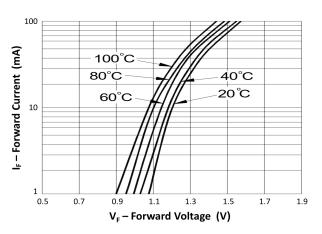


Fig 6 Forward Current vs Forward Voltage



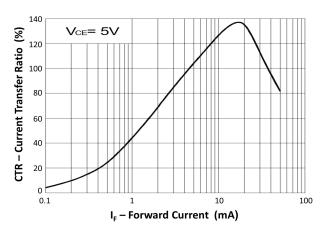


Fig 7 Current Transfer Ratio vs Forward Current

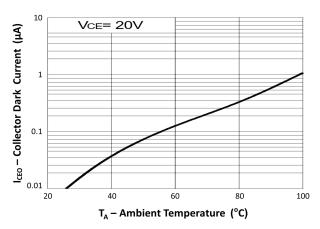


Fig 9 Collector Dark Current vs Ambient Temperature

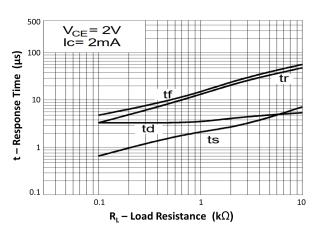


Fig 11 Response Time vs Load Resistance

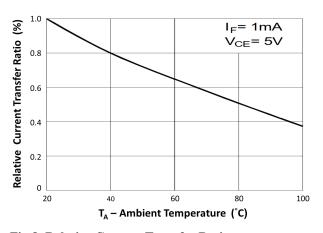


Fig 8 Relative Current Transfer Ratio vs Ambient Temperature

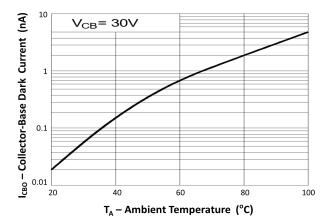


Fig 10 Collector-Base Dark Current vs Ambient Temperature

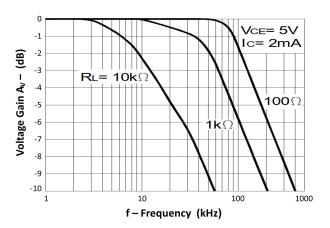


Fig 12 Frequency Response



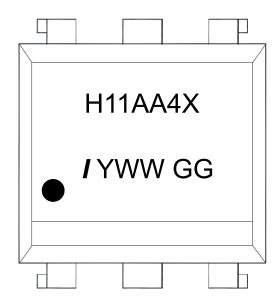
ORDER INFORMATION

H11AA1, H11AA2, H11AA3, H11AA4 (UL Approval)				
After PN	PN	Description	Packing quantity	
None	H11AA1, H11AA2, H11AA3, H11AA4	Standard DIP6	65 pcs per tube	
G	H11AA1G, H11AA2G H11AA3G, H11AA4G	10mm Lead Spacing	65 pcs per tube	
SM	H11AA1SM, H11AA2SM H11AA3SM, H11AA4SM	Surface Mount	65 pcs per tube	
SMT&R	H11AA1SMT&R, H11AA2SMT&R H11AA3SMT&R, H11AA4SMT&R	Surface Mount Tape and Reel	1000 pcs per reel	

	H11AA1X, H11AA2X, H11AA3X, H11AA4X (UL and VDE Approvals)				
After PN	PN	Description	Packing quantity		
None	H11AA1X, H11AA2X H11AA3X, H11AA4X	Standard DIP6	65 pcs per tube		
G	H11AA1XG, H11AA2XG H11AA3XG, H11AA4XG	10mm Lead Spacing	65 pcs per tube		
SM	H11AA1XSM, H11AA2XSM H11AA3XSM, H11AA4XSM	Surface Mount	65 pcs per tube		
SMT&R	H11AA1XSMT&R H11AA2XSMT&R H11AAX3SMT&R H11AA4XSMT&R	Surface Mount Tape and Reel	1000 pcs per reel		



DEVICE MARKING Example : H11AA4X



H11AA4X denotes Device Part Number

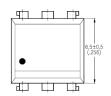
I denotes Isocom

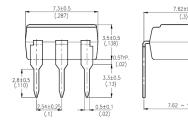
Y denotes 1 digit Year code WW denotes 2 digit Week code



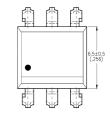
PACKAGE DIMENSIONS (mm)

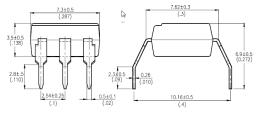
DIP



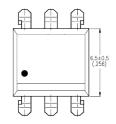


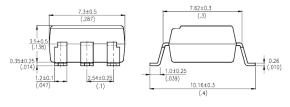
G Form





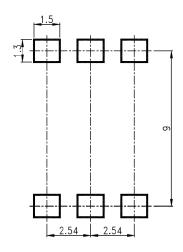
Surface Mount



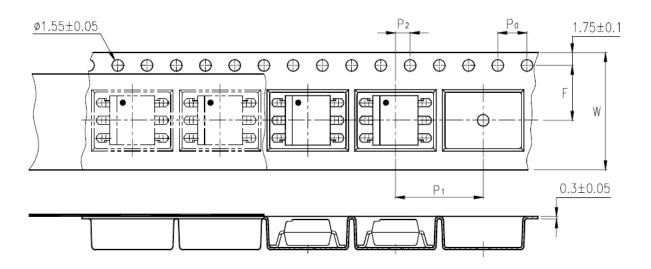




RECOMMENDED PAD LAYOUT FOR SMD (MM)



TAPE AND REEL PACKAGING

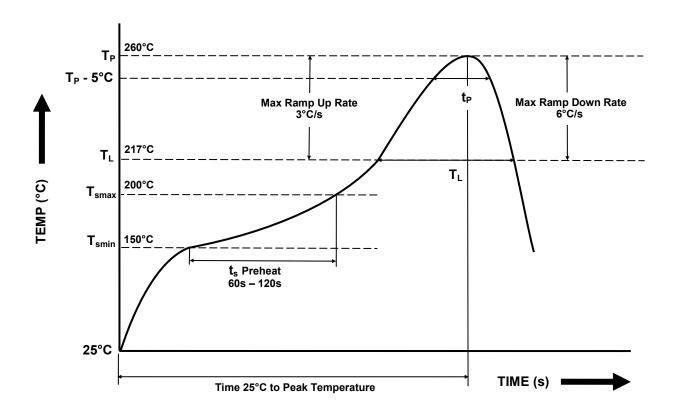


Description	Symbol	Dimension mm (inch)
Tape Width	W	16 ± 0.3 (0.63)
Pitch of Sprocket Holes	P ₀	4 ± 0.1 (0.15)
Distance of Compartment to Sprocket Holes	F	7.5 ± 0.1 (0.295)
Distance of Compartment to Sprocket Holes	P ₂	2 ± 0.1 (0.079)
Distance of Compartment to Compartment	P ₁	12 ± 0.1 (0.472)



IR REFLOW SOLDERING TEMPERATURE PROFILE

One Time Reflow Soldering is Recommended. Do not immerse device body in solder paste.



Profile Details	Conditions
$ \begin{array}{l} \textbf{Preheat} \\ \textbf{- Min Temperature } (T_{SMIN}) \\ \textbf{- Max Temperature } (T_{SMAX}) \\ \textbf{- Time } T_{SMIN} \ \text{to } T_{SMAX} \left(t_s \right) \end{array} $	150°C 200°C 60s - 120s
$\begin{tabular}{lll} \textbf{Soldering Zone} \\ &- \mbox{Peak Temperature } (T_P) \\ &- \mbox{Time at Peak Temperature} \\ &- \mbox{Liquidous Temperature } (T_L) \\ &- \mbox{Time within } 5^{\circ}\mbox{C of Actual Peak Temperature } (T_P - 5^{\circ}\mbox{C}) \\ &- \mbox{Time maintained above } T_L (t_L) \\ &- \mbox{Ramp Up Rate } (T_L \mbox{ to } T_P) \\ &- \mbox{Ramp Down Rate } (T_P \mbox{ to } T_L) \\ \end{tabular}$	260°C 10s max 217°C 30s max 60s - 100s 3°C/s max 6°C/s max
Average Ramp Up Rate (T _{smax} to T _P)	3°C/s max
Time 25°C to Peak Temperature	8 minutes max



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